

High **VOLT** Interactive

Where power supply design meets collaboration

Designing reliable and high density power solutions with GaN

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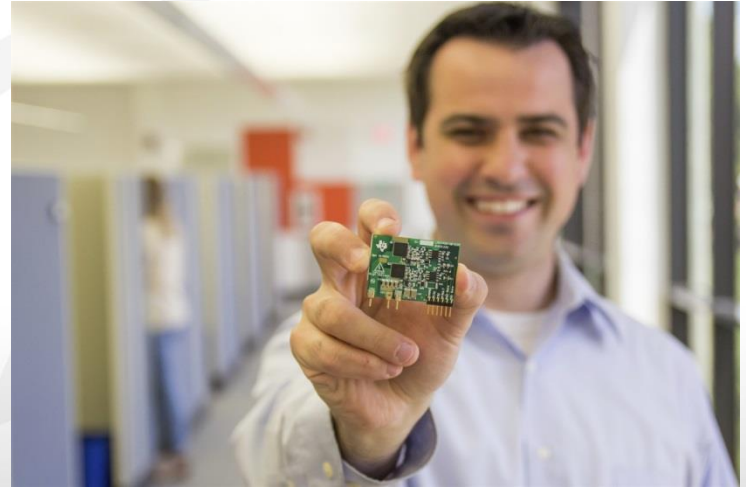
Presented by: Paul L Brohlin

What will I get out of this presentation?

- Why GaN?
- Integration for System Performance and Reliability
- GaN Applications
- Relevant Part Numbers
 - LMG3410Rxxx/LMG3411Rxxx
 - LMG5200

GaN: Ready to Take you Beyond Silicon Today

- GaN devices are enabling solutions with twice the power density of what is possible with best-in-class superjunction FETs
- TI GaN solutions, such as LMG5200 and LMG3410R070, are in mass production and in many customer systems
- These systems are not only smaller and more efficient, but are also in cost and system parity with their silicon predecessors.
- Lets find out how!



GaN: Unmatched Power Density from AC-to-Motor

SMALLER:

99% efficient 1.6kW
1MHz CrM PFC



250 W/in³ (15 W/cm³)

105 x 80 mm

LMG3410x, UCD3138, UCC27714

FASTER:

1MHz 1kW Isolated
DC/DC LLC



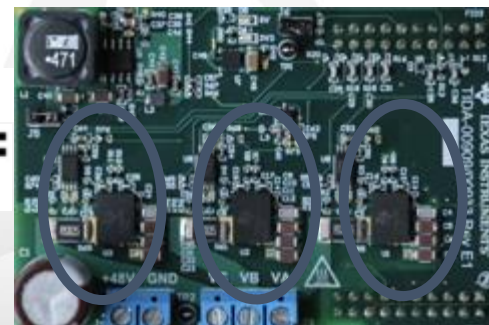
140 W/in³ (8.5 W/cm³)

94 x 84 mm

LMG3410x, UCD3138

COOLER:

48V/10A 3-Phase
100kHz Inverter



No Heatsink!

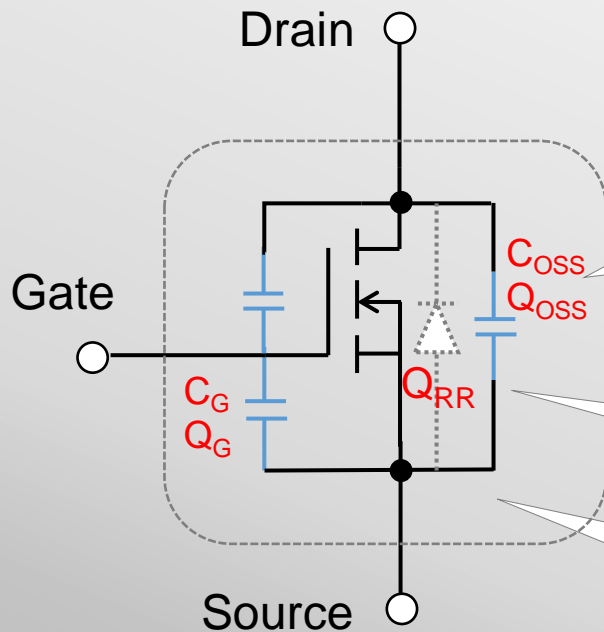
500 W/in³ (30 W/cm³)

79 x 53 mm

LMG5200, UCD9322



GaN 101: Key Advantages Over Silicon



Low C_G, Q_G gate capacitance/charge (1 nC- Ω vs Si 4 nC- Ω)

- ✓ faster turn-on and turn-off, higher switching speed
- ✓ reduced gate drive losses

Low C_{OSS}, Q_{OSS} output capacitance/charge (5 nC- Ω vs Si 25 nC- Ω)

- ✓ faster switching, high switching frequencies
- ✓ reduced switching losses

Low $R_{DS(ON)}$ (5 m Ω -cm² vs Si >10 m Ω -cm²)

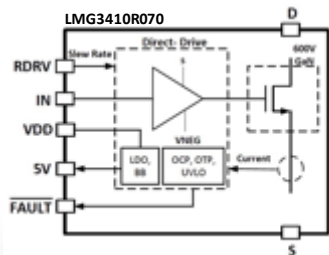
- ✓ lower conduction losses

Zero Q_{RR} No 'body diode'

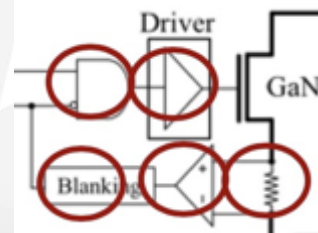
- ✓ No reverse recovery losses
- ✓ Reduces ringing on switch node and EMI

Not All GaN is Created Equal

TI GaN: Fully Integrated



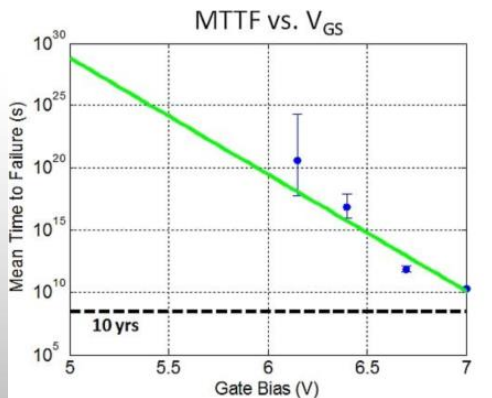
Discrete GaN



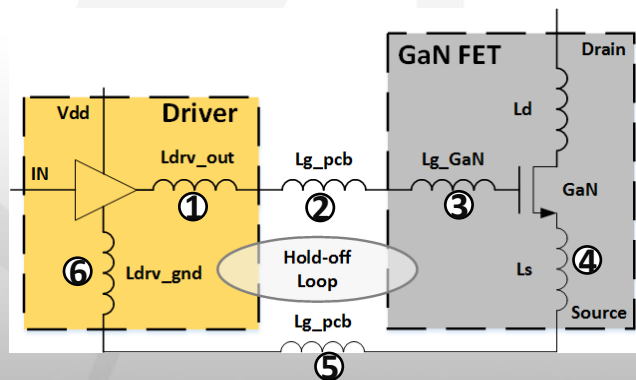
Driver	Integrated	External
EMI Control	Integrated	External
100ns OCP	Integrated	External
Added PCB Area	0	>400mm ²

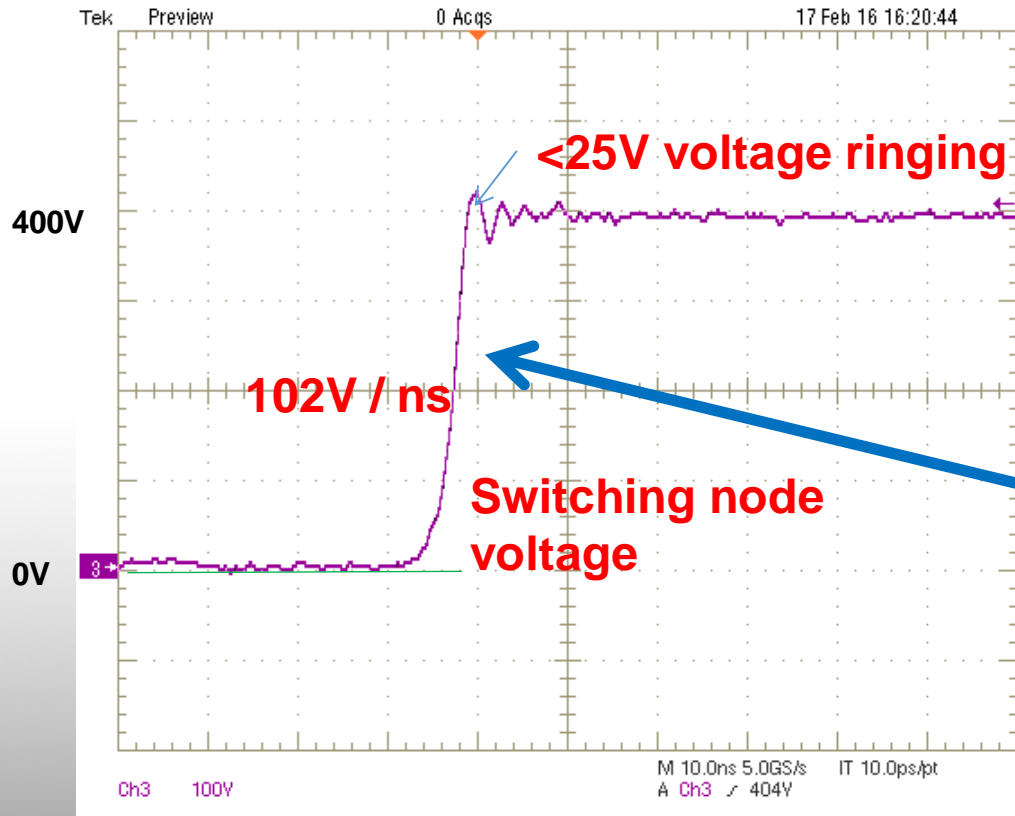
Challenges of GaN Designs with External Driver

- **Driver Bias Voltage:** GaN gate bias is critical to its performance and long-term device reliability



- **Parasitic Inductance:** causes switching loss, ringing and reliability issues, especially at high GaN frequencies





Zero to 400V in <4ns
With TI-GaN

Captured with 1GHz Passive Voltage
Probe – Tektronix TPP1000

Integrated Overcurrent Protection

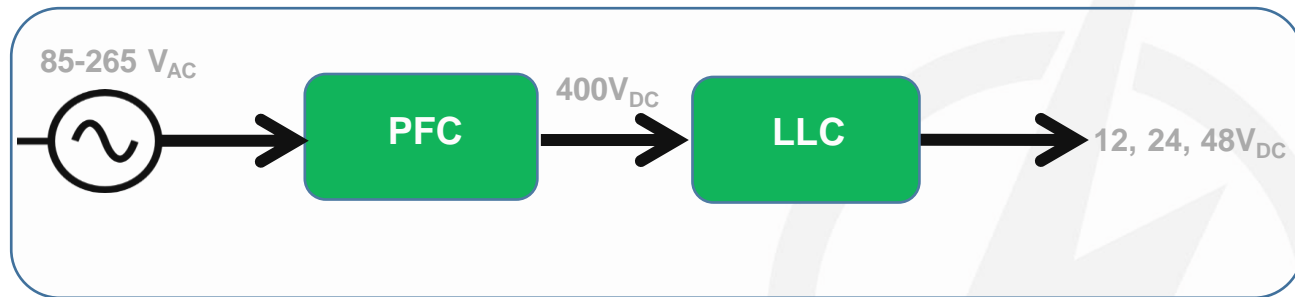
OCP Option	OCP Performance	System Impact	Cost
Resistive Shunt	<ul style="list-style-type: none"> Poor SNR 	<ul style="list-style-type: none"> High power loop inductance Power losses 	<ul style="list-style-type: none"> Sense resistor High speed comparator (--)
TI GAN- Integrated OCP	<100ns Response	None	No external components

- High value sense resistor is needed for SNR
- Increases power loop which slows down the dv/dt for the given overshoot (100V/ns drops to 80V/ns)
- Increased power losses due lower dv/dt and sense resistor

Parameter	Resistive Shunt 2X 12mΩ (25mΩ /2)
Added PCB Area	233 mm ²
Added Power Loop Inductance	1.2nH
dv/dt	80V/ns
Additional Power Loss at 100kHz Po=1.2kW	0.9W

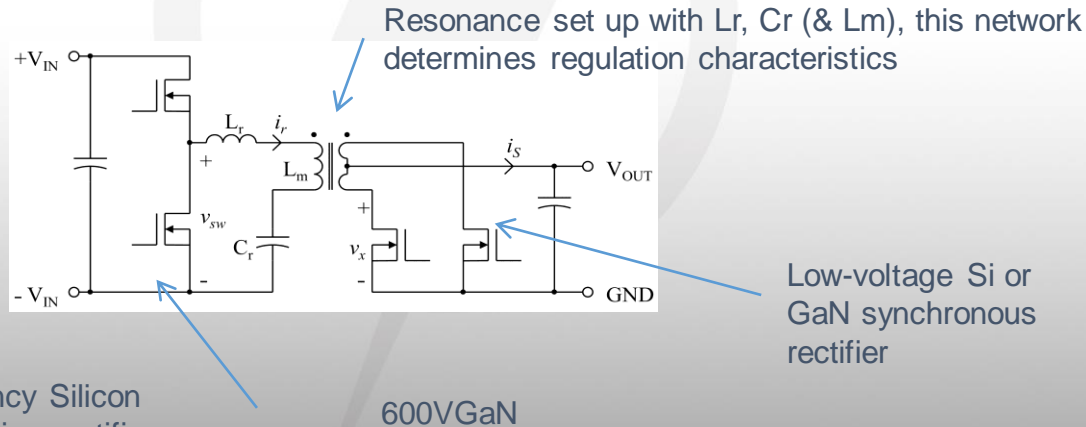
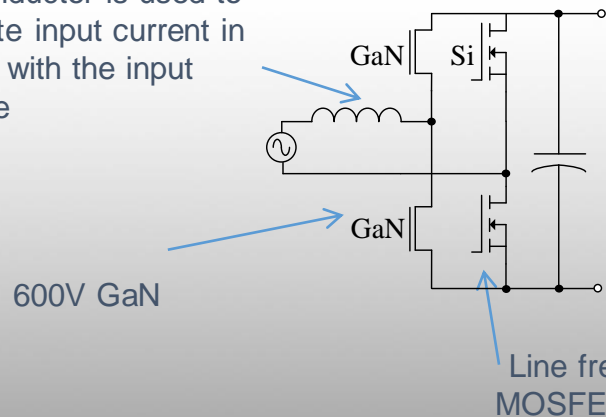
GaN Application Examples

AC/DC: Applications and Topology



Typical AC/DC PSU for industrial, medical, telecomm and server applications.

PFC inductor is used to regulate input current in phase with the input voltage

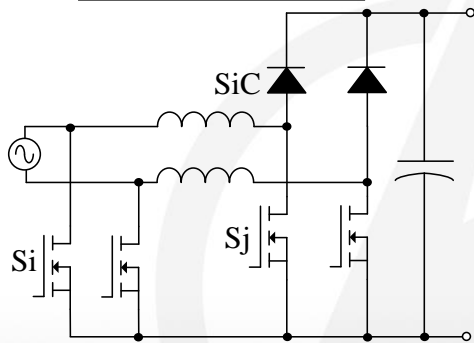




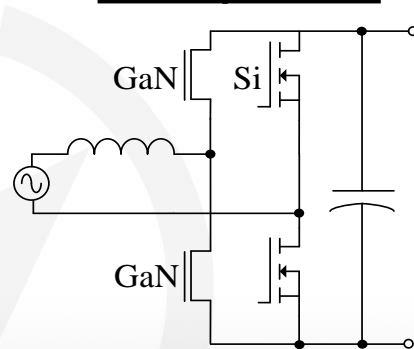
GaN CCM Solution: Superior Power Supply Design

- **Higher efficiency**
 - Reduced power loss by 36%
- **Higher power density**
 - 3X power density in Totem-pole PFC versus Silicon
- **Solution cost parity**
 - Reduced magnetics and external components bring total solution cost down

Dual boost PFC



Totem-pole PFC



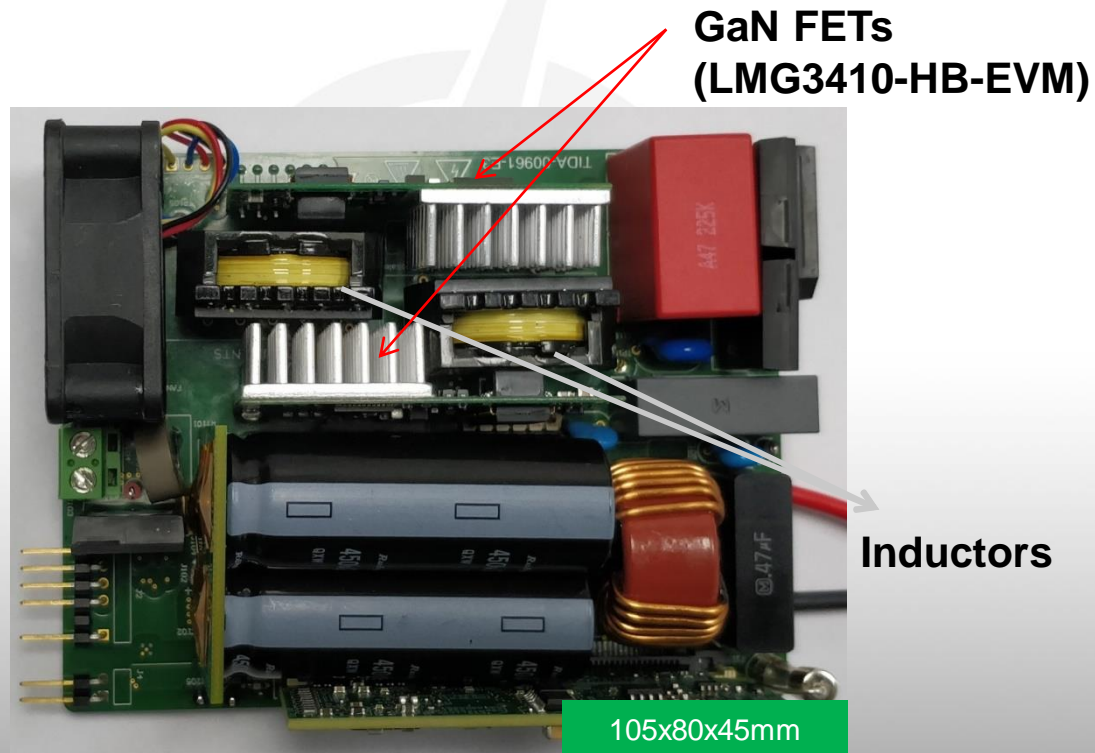
Loss Mechanism	Dual Boost PFC with Silicon	Totem-pole PFC with GaN
Switching FET Cond.	0.6 W	2.06 W
SiC Diode Cond.	2.75W	-
FET E_{oss} / SiC Diode Q_{oss}	3.9 W	2.4W
I-V Overlap	1.47 W	0.95W
Rect. Diodes / FETs	0.45 W (FET)	0.45 W (FET)
Total Power Losses	9.17W	5.86W



GaN CrM Solution: 1.6kW Totem-Pole PFC

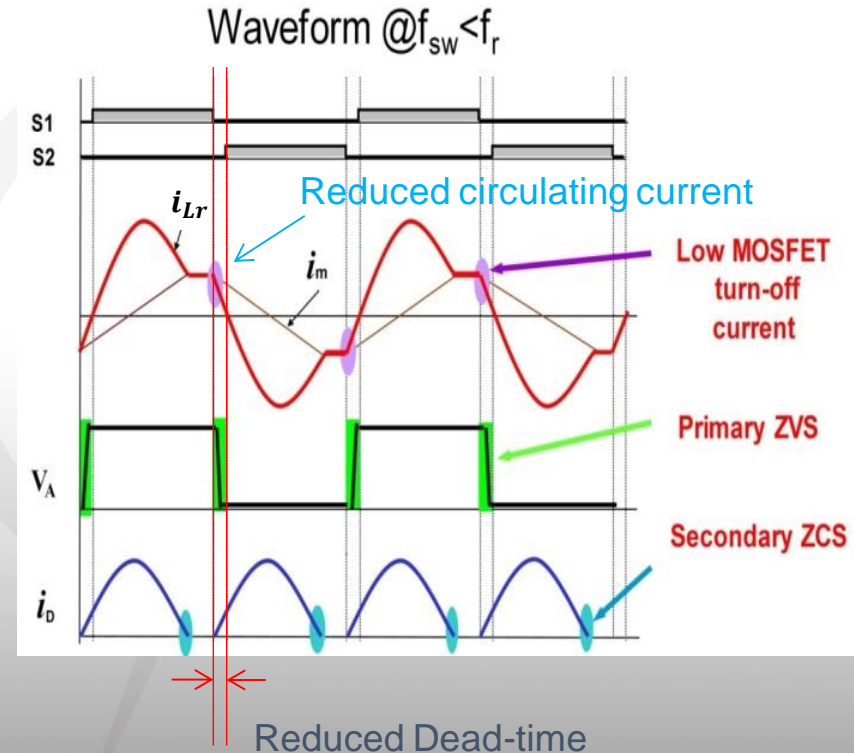
Parameter	Value
Input Voltage	85 – 265 V _{AC}
Input Frequency	50 – 60 Hz
Output Voltage	385 V _{DC}
Output Power	1.6 kW
Switching Frequency	1MHz

**Power Density: 250 W/in³
(15.3 W/cm³)**



GaN in LCC: Superior Power Supply Design

- **Reduced Output Capacitance C_{OSS}**
 - reduces dead-time, increasing the time when current delivered to the output
 - allows larger magnetizing inductance and lower circulating current losses as well as transformer fringe-field losses
- **Reduced Gate Driver Losses**
- **System Optimization**
 - GaN enables higher switching frequency to reduce magnetic components significantly
 - GaN enables LLC converter with higher efficiency and higher power density

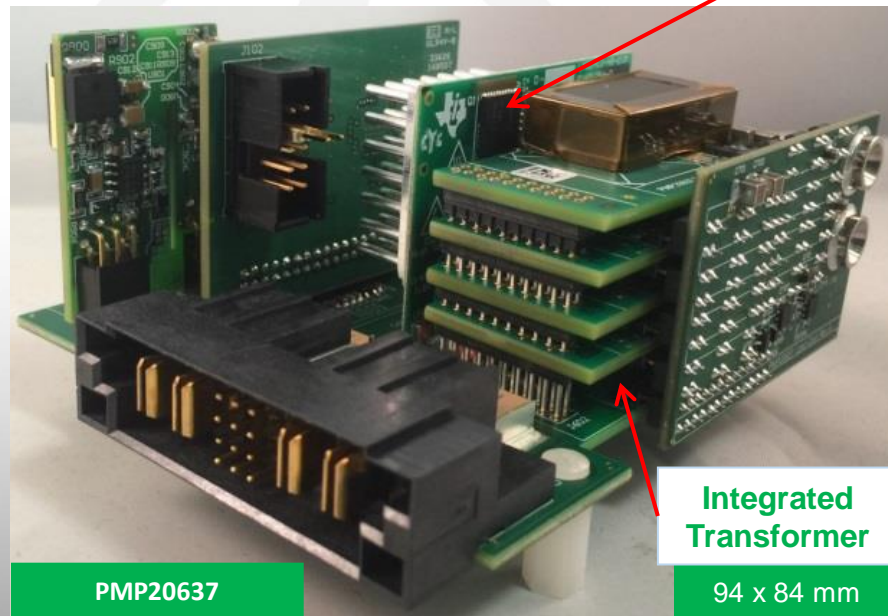


TI-GaN: 1MHz Isolated LLC DCDC Converter

Parameter	Value
Input Voltage	380 – 400V
Output Voltage	48V
Output Power	1 kW
Switching Frequency	1MHz
Efficiency	>97%

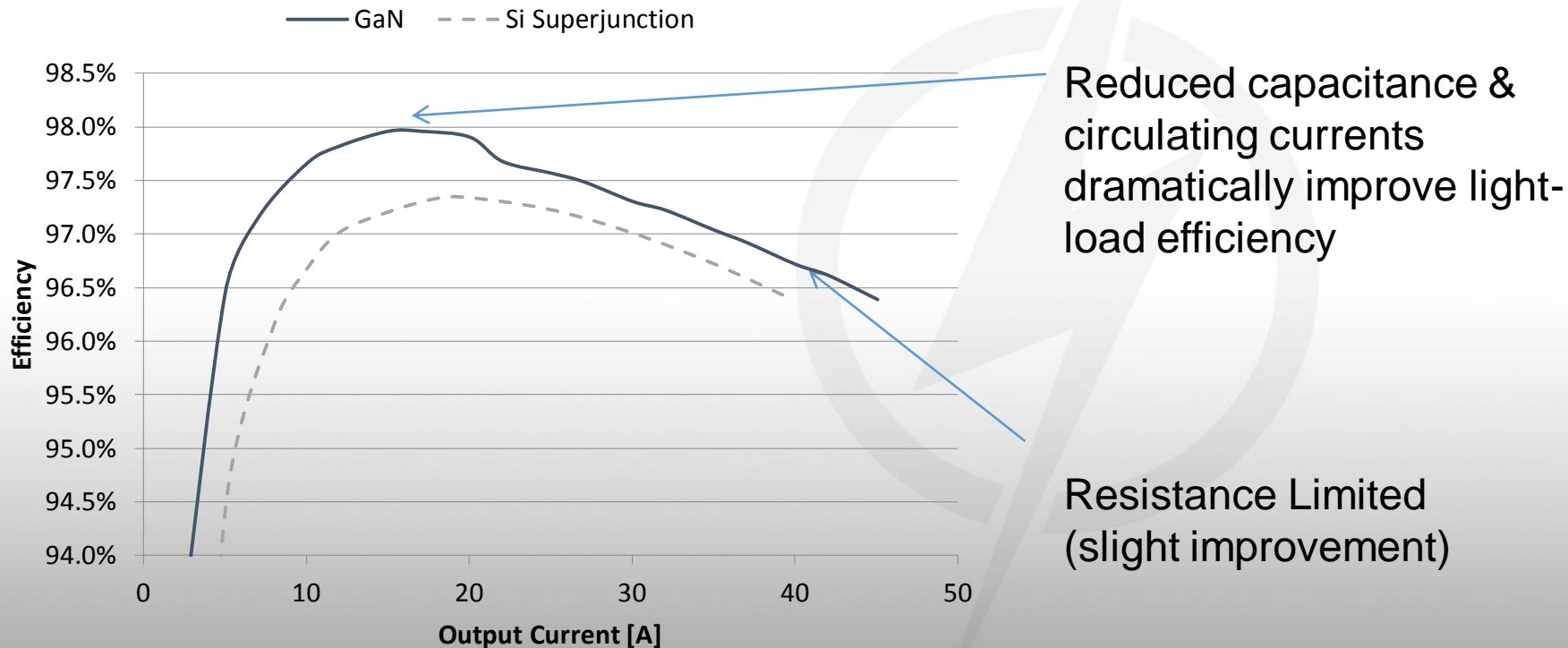
Power Density: 140 W/in³
(8.5 W/cm³)

GaN FETs
(LMG3410-HB-EVM)





Efficiency: Comparison with MOSFET





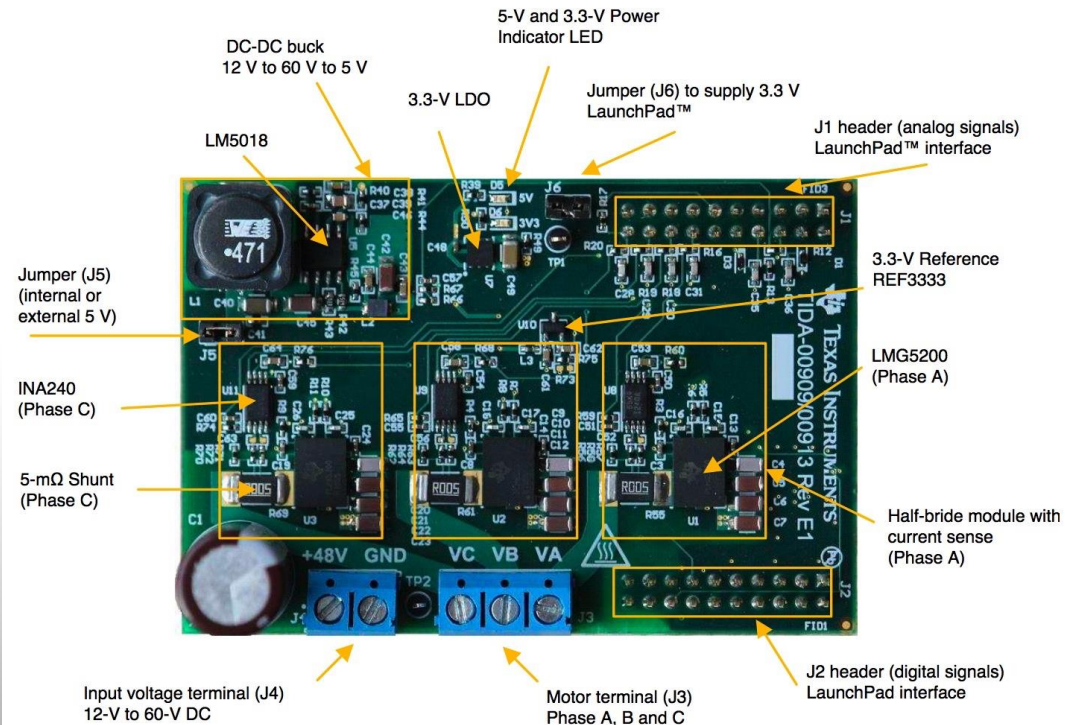
GaN: Enabling Smart Motor Drive

- GaN reduces or eliminates heatsink
- GaN reduces or eliminates switch node oscillations
 - Lower radiated EMI, no additional snubber network (space, losses) required
- GaN increases PWM frequency and reduces switching losses
 - Drive very low inductance PM synchronous motors or BLDC motors
 - Precise positioning in servo drives/steppers through minimum torque ripple
 - High-speed motors (e.g. drone) achieves sinusoidal voltage above 1-2kHz frequency
- GaN eliminates dead-time distortions of phase voltage
 - Better light load and THD performance

48V 10A 3 Φ Inverter for High-Speed Motors

Parameter	Value
Input Voltage	12 – 60 V _{DC}
Input Power	400W
Output Voltage	48 V _{DC}
Output Current	10-A _{Peak}
Switching Frequency	100 kHz
Peak Efficiency	98.5%

**Power Density: 500 W/in³
(30.5 W/cm³)**



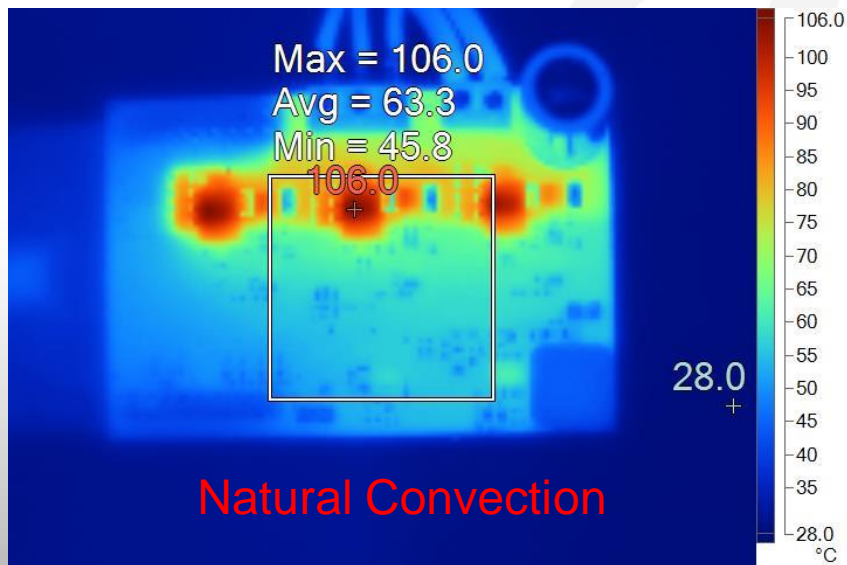
TIDA-00909

Board dimension 54mm * 79mm



48V GaN Inverter: Thermal Performance

48V/10A with 98.5% Efficiency



No Heatsink!

Conclusion

- GaN is enabling a new generation of power conversion designs today, that were not possible before
- GaN enables 3X power density improvement from AC to Point-of-Load
- Integration of GaN FET, driver, and protection in a low inductance package provides an optimal solution for fast and reliable switching
- For products, designs, and training material, visit [TI.com/GaN](https://www.ti.com/GaN)